

# BBS3002-VB Datasheet

## P-Channel 60 V (D-S) 175 °C MOSFET

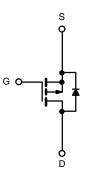
| PRODUCT SUMMARY     |   |      |  |  |  |
|---------------------|---|------|--|--|--|
| V <sub>DS</sub> (V) | <sub>DS</sub> (V) R <sub>DS(on)</sub> (Ω) |      |  |  |  |
| -60                 | 0.0050 at V <sub>GS</sub> = -10 V         | -120 |  |  |  |
|                     | 0.0070 at $V_{GS}$ = -4.5 V               | -120 |  |  |  |



### FEATURES

- Trench power MOSFET
- Package with low thermal resistance





P-Channel MOSFET

| <b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C = 25 \text{ °C}$ , unless otherwise noted) |                                     |                                   |             |    |  |  |
|---|-------------------------------------|-----------------------------------|-------------|----|--|--|
| PARAMETER   | SYMBOL                              | LIMIT                             | UNIT        |    |  |  |
| Drain-Source Voltage  | V <sub>DS</sub>                     | -60                               | V           |    |  |  |
| Gate-Source Voltage   | V <sub>GS</sub>                     | ± 20                              | v           |    |  |  |
| Continuous Drain Current <sup>d</sup>   | T <sub>C</sub> = 25 °C              |                                   | -120        |    |  |  |
| (T <sub>J</sub> = 175 °C)   | T <sub>C</sub> = 125 °C             |                                   | -95         |    |  |  |
| Pulsed Drain Current  | I <sub>DM</sub>                     | -350                              | A           |    |  |  |
| Avalanche Current   | L = 0.1 mH                          | I <sub>AS</sub>                   | -75         |    |  |  |
| Single Pulse Avalanche Energy <sup>a</sup>  | L = 0.1 MH                          | E <sub>AS</sub>                   | 281         | mJ |  |  |
| Dower Dissingtion   | T <sub>C</sub> = 25 °C °            | D                                 | 375         | w  |  |  |
| Power Dissipation   | T <sub>A</sub> = 25 °C <sup>b</sup> | P <sub>D</sub> —                  | 3.75        |    |  |  |
| Operating Junction and Storage Temperature Range                                  |                                     | T <sub>J</sub> , T <sub>stg</sub> | -55 to +175 | °C |  |  |

| THERMAL RESISTANCE RATINGS |                        |                   |         |      |  |  |
|----------------------------|------------------------|-------------------|---------|------|--|--|
| PARAMETER                  |                        | SYMBOL            | TYPICAL | UNIT |  |  |
| Junction-to-Ambient        | PCB mount <sup>b</sup> | R <sub>thJA</sub> | 40      | °C/W |  |  |
| Junction-to-Case           |                        | R <sub>thJC</sub> | 0.4     | 0/11 |  |  |

#### Notes

- a. Duty cycle  $\leq$  1 %.
- b. When mounted on 1" square PCB (FR4 material).
- c. See SOA curve for voltage derating.
- d. Limited by package.

| <b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted) |                             |   |      |        |       |      |  |
|--|-----------------------------|---|------|--------|-------|------|--|
| PARAMETER  | SYMBOL                      | TEST CONDITIONS   | MIN. | TYP.   | MAX.  | UNIT |  |
| Static   |                             |   |      |        |       | [    |  |
| Drain-Source Breakdown Voltage   | V <sub>DS</sub>             | $V_{GS} = 0 V, I_D = -250 \mu A$  | -60  | -      | -     | v    |  |
| Gate Threshold Voltage   | V <sub>GS(th)</sub>         | $V_{DS} = V_{GS}, I_D = -250 \ \mu A$   | -1   | -      | -3    |      |  |
| Gate-Body Leakage  | I <sub>GSS</sub>            | $V_{DS} = 0 V, V_{GS} = \pm 20 V$   | -    | -      | ± 100 | nA   |  |
|  |                             | $V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$                              | -    | -      | -1    | μA   |  |
| Zero Gate Voltage Drain Current  | I <sub>DSS</sub>            | $V_{DS}$ = -60 V, $V_{GS}$ = 0 V, $T_{J}$ = 125 °C                                  | -    | -      | -50   |      |  |
|  |                             | $V_{DS}$ = -60 V, $V_{GS}$ = 0 V, $T_{J}$ = 175 °C                                  | -    | -      | -250  |      |  |
| On-State Drain Current <sup>a</sup>                                    | I <sub>D(on)</sub>          | $V_{DS} = -5 V, V_{GS} = -10 V$   | -120 | -      | -     | Α    |  |
|  |                             | $V_{GS} = -10 \text{ V}, \text{ I}_{D} = -30 \text{ A}$                             | -    | 0.0050 | -     |      |  |
| Drain-Source On-State Resistance <sup>a</sup>                          | Б                           | $V_{GS}$ = -10 V, $I_D$ = -30 A, $T_J$ = 125 °C                                     | -    | 0.0115 | -     | Ω    |  |
| Drain-Source On-State Resistance                                       | R <sub>DS(on)</sub>         | $V_{GS}$ = -10 V, $I_D$ = -30 A, $T_J$ = 175 °C                                     | -    | 0.0138 | -     |      |  |
|  |                             | $V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -20 \text{ A}$                            | -    | 0.0070 | -     |      |  |
| Forward Transconductance <sup>a</sup>                                  | 9 <sub>fs</sub>             | V <sub>DS</sub> = -15 V, I <sub>D</sub> = -50 A                                     | 20   | -      | -     | S    |  |
| Dynamic <sup>b</sup>   |                             |   |      |        |       |      |  |
| Input Capacitance  | C <sub>iss</sub>            |   | -    | 11 400 | -     | pF   |  |
| Output Capacitance   | Coss                        | $V_{GS} = 0 V$ , $V_{DS} = -25 V$ , f = 1 MHz                                       | -    | 1200   | -     |      |  |
| Reverse Transfer Capacitance   | C <sub>rss</sub>            |   | -    | 900    | -     |      |  |
| Total Gate Charge <sup>c</sup>   | Qg                          |   | -    | 230    | 345   | nC   |  |
| Gate-Source Charge <sup>c</sup>  | Q <sub>gs</sub>             | $V_{DS} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -110 \text{ A}$              | -    | 50     | -     |      |  |
| Gate-Drain Charge <sup>c</sup>   | Q <sub>gd</sub>             |   | -    | 60     | -     |      |  |
| Gate Resistance  | R <sub>g</sub>              | f = 1 MHz   | -    | 3      | -     | Ω    |  |
| Turn-On Delay Time <sup>c</sup>  | t <sub>d(on)</sub>          |   | -    | 20     | 30    |      |  |
| Rise Time <sup>c</sup>   | t <sub>r</sub>              | $V_{DD} = -30 \text{ V}, \text{ R}_{\text{I}} = 0.27 \Omega$                        | -    | 25     | 40    | ns   |  |
| Turn-Off Delay Time <sup>c</sup>                                       | t <sub>d(off)</sub>         | $I_D\cong -110~\text{A},~V_{\text{GEN}}=-10~\text{V},~\text{R}_{\text{g}}=1~\Omega$ | -    | 110    | 200   |      |  |
| Fall Time <sup>c</sup>   | t <sub>f</sub>              |   | -    | 50     | 100   |      |  |
| Drain-Source Body Diode Character                                      | istics (T <sub>C</sub> = 25 | o °C ♭)   |      |        |       |      |  |
| Continuous Current   | I <sub>S</sub>              |   | -    | -      | -110  | ^    |  |
| Pulsed Current   | I <sub>SM</sub>             |   | -    | -      | -240  | A    |  |
| Forward Voltage <sup>a</sup>   | V <sub>SD</sub>             | I <sub>F</sub> = -85 A, V <sub>GS</sub> = 0 V                                       | -    | -1     | -1.5  | V    |  |
| Reverse Recovery Time  | t <sub>rr</sub>             |   | -    | 91     | 137   | ns   |  |
| Peak Reverse Recovery Charge   | I <sub>RM(REC)</sub>        | I <sub>F</sub> = -85 A, dl/dt = 100 A/µs  | -    | -6     | -9    | А    |  |
| Reverse Recovery Charge  | Q <sub>rr</sub>             |   | -    | 0.21   | 0.44  | μC   |  |

Notes

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



T<sub>C</sub> = 125 °C

3

-55 °C

4

 $V_{GS} = 10 V$ 

100

120

80

5

25 °C

2

V<sub>GS</sub> = 4.5 V

60

I<sub>D</sub> - Drain Current (A)

40

150

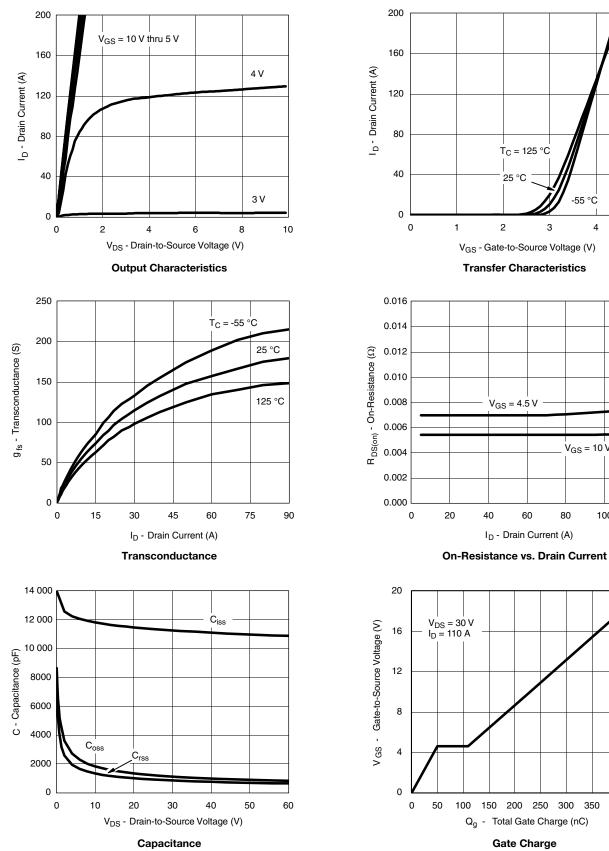
200 250 300

Total Gate Charge (nC)

**Gate Charge** 

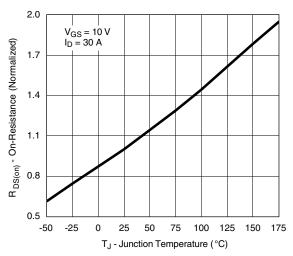
350

400 450

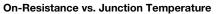


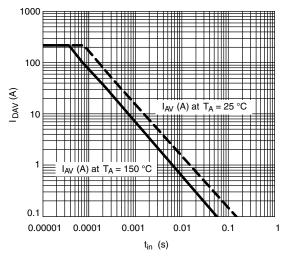
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



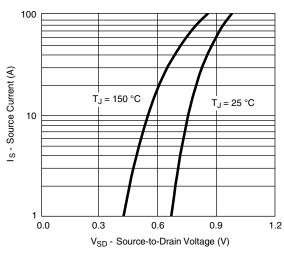


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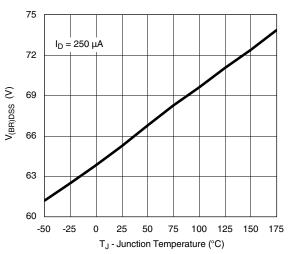




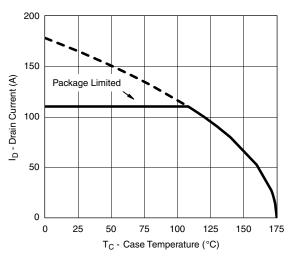




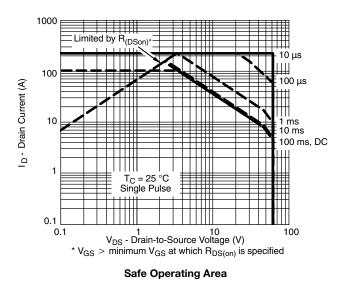
Source-Drain Diode Forward Voltage



Drain Source Breakdown vs. Junction Temperature

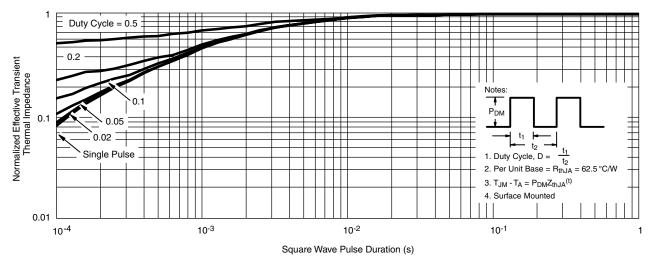


Maximum Avalanche and Drain Current vs. Case Temperature





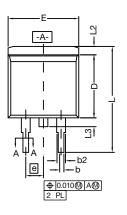
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

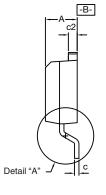


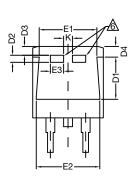
Normalized Thermal Transient Impedance, Junction-to-Case



## TO-263 (D<sup>2</sup>PAK): 3-LEAD

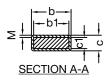








DETAIL A (ROTATED 90°)



|  |            | INC       | HES   | MILLIMETERS |        |  |  |
|--|------------|-----------|-------|-------------|--------|--|--|
| DIM.   |            | MIN.      | MAX.  | MIN.        | MAX.   |  |  |
| А  |            | 0.160     | 0.190 | 4.064       | 4.826  |  |  |
| b  |            | 0.020     | 0.039 | 0.508       | 0.990  |  |  |
|  | b1         | 0.020     | 0.035 | 0.508       | 0.889  |  |  |
|  | b2         | 0.045     | 0.055 | 1.143       | 1.397  |  |  |
| с*   | Thin lead  | 0.013     | 0.018 | 0.330       | 0.457  |  |  |
| C  | Thick lead | 0.023     | 0.028 | 0.584       | 0.711  |  |  |
| c1   | Thin lead  | 0.013     | 0.017 | 0.330       | 0.431  |  |  |
| CI   | Thick lead | 0.023     | 0.027 | 0.584       | 0.685  |  |  |
| c2   |            | 0.045     | 0.055 | 1.143       | 1.397  |  |  |
|  | D          | 0.340     | 0.380 | 8.636       | 9.652  |  |  |
| D1   |            | 0.220     | 0.240 | 5.588       | 6.096  |  |  |
| D2   |            | 0.038     | 0.042 | 0.965       | 1.067  |  |  |
| D3   |            | 0.045     | 0.055 | 1.143       | 1.397  |  |  |
| D4   |            | 0.044     | 0.052 | 1.118       | 1.321  |  |  |
|  | E          | 0.380     | 0.410 | 9.652       | 10.414 |  |  |
|  | E1         | 0.245     | -     | 6.223       | -      |  |  |
| E2   |            | 0.355     | 0.375 | 9.017       | 9.525  |  |  |
| E3   |            | 0.072     | 0.078 | 1.829       | 1.981  |  |  |
|  | е          | 0.100     | BSC   | 2.54        | BSC    |  |  |
|  | К          | 0.045     | 0.055 | 1.143       | 1.397  |  |  |
| L  |            | 0.575     | 0.625 | 14.605      | 15.875 |  |  |
| L1   |            | 0.090     | 0.110 | 2.286       | 2.794  |  |  |
| L2   |            | 0.040     | 0.055 | 1.016       | 1.397  |  |  |
| L3   |            | 0.050     | 0.070 | 1.270       | 1.778  |  |  |
|  | L4         | 0.010 BSC |       | 0.254 BSC   |        |  |  |
| М  |            | -         | 0.002 | -           | 0.050  |  |  |
| ECN: T13-0707-Rev. K, 30-Sep-13<br>DWG: 5843 |            |           |       |             |        |  |  |

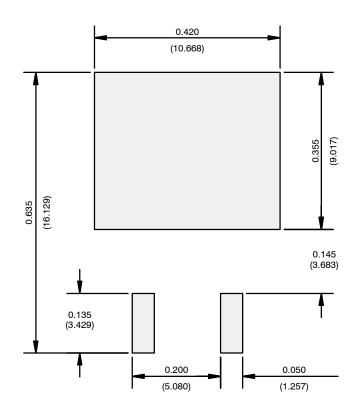
#### Notes

- 1. Plane B includes maximum features of heat sink tab and plastic. 2. No more than 25 % of L1 can fall above seating plane by
- max. 8 mils.3. Pin-to-pin coplanarity max. 4 mils.
- 4. \*: Thin lead is for SUB, SYB.
  - Thick lead is for SUM, SYM, SQM.
- 5. Use inches as the primary measurement.

This feature is for thick lead.







Recommended Minimum Pads Dimensions in Inches/(mm)



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